

Notice of References Cited	Application/Control No. 09/854,474	Applicant(s)/Patent Under Reexamination YAMANAKA, YOSHIMICHI	
	Examiner Christopher M. Keehan	Art Unit 1712	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,451,439 B2	09-2002	Okamoto et al.	428/447
	B	US-6,273,985 B1	08-2001	DeLouise et al.	156/273.3
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

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